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Particle size analysis - Laser diffraction methods (ISO 13320:2020)

Contents		Page
National foreword		4
National Annex NA (informative) Bibliography		5
Foreword		6
Introduction		7
1	Scope	8
2	Normative references	8
3	Terms, definitions and symbols	8
	3.1 Terms and definitions	8
	3.2 Symbols	13
4	Principle	15
	4.1 General	15
	4.2 Theory	15
	4.3 Typical instrument and optical arrangement	16
	4.4 Measurement zone	18
	4.5 Application and sample presentation	18
	4.6 Off-line measurements	19
	4.7 In-line measurements	19
	4.8 Online measurements	19
	4.9 At-line measurements	20
	4.10 Scattering and detectors	20
5	Operational requirements and procedures	20
	5.1 Instrument location	20
	5.2 Dispersion gases	20
	5.3 Dispersion liquids	21
	5.4 Sample inspection, preparation, dispersion and concentration	21
	5.4.1 Sample inspection	21
	5.4.2 Preparation	21
	5.4.3 Dispersion	21
	5.4.4 Concentration	22
	5.5 Measurement	22
	5.5.1 Setting up instrument and blank measurement	22
	5.5.2 Sample preparation	23
	5.5.3 Data collection of the scattering pattern	23
	5.5.4 Selection of an appropriate optical model	23
	5.5.5 Conversion of scattering pattern into PSD	23
	5.5.6 Robustness	24
	5.6 Resolution and sensitivity	24
	5.6.1 General	24
	5.6.2 Resolution	24
	5.6.3 Sensitivity and result variability	24
6	Accuracy repeatability and instrument qualification	25
	6.1 General	25
	6.2 Accuracy	26
	6.2.1 Introduction	26
	6.2.2 Accuracy test	26

6.3	Instrument repeatability	26
6.3.1	Introduction	26
6.3.2	Repeatability test	26
6.4	Method repeatability	27
6.4.1	Introduction	27
6.4.2	Method repeatability test	27
6.5	Accuracy under intermediate precision conditions	27
6.5.1	General	27
6.5.2	Intermediate precision conditions (general test)	28
7	Reporting of results	28
7.1	General	28
7.2	Sample	28
7.3	Dispersion	29
7.4	Laser diffraction measurement	29
7.5	Analyst identification:	29
	Annex A (informative) Theoretical background of laser diffraction	31
	Annex B (informative) Advice on dispersion liquids	48
	Annex C (informative) Dispersion methods — Recommendations	49
	Annex D (informative) Instrument preparation — Recommendations	51
	Annex E (informative) Error sources and diagnosis	53
	Annex F (informative) Refractive index — Recommendations	56
	Annex G (informative) Laser diffraction robustness and ruggedness	58
	Annex H (normative) Certified reference materials, reference materials and comparison parameters	61
	Bibliography	64